## Applicant(s)/Patent Under Application/Control No. Reexamination 10/560,155 WASHIO ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 1752 Hoa V. Le **U.S. PATENT DOCUMENTS** Date **Document Number** Classification Name Country Code-Number-Kind Code MM-YYYY Kanda, Takashi 427/162 US-2003/0091732 05-2003 Α US-В US-С US-D US-Ε US-F US-G USн US-US-US-Κ US-

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